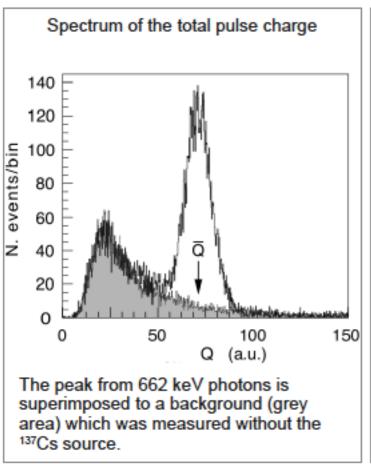
## Dependence of the Energy Resolution of a Scintillating Crystal on the Read-Out Integration Time

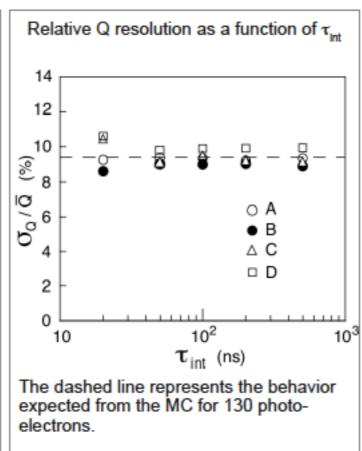
## Motivation of the study

When using detectors made of crystals and photo-detectors in high rate applications it is not always possible to integrate the whole signal because it can be too long compared to the maximum permitted integration time to avoid the pile-up.

An experimental test with a BGO crystal, readout by a photomultiplier and a Monte Carlo simulation demonstrates that, when the number of photoelectrons is large, the energy resolution obtained by a peak-sensitive acquisition scales as  $1/\sqrt{N_{int}}$  where  $N_{int}$  is the average number of emitted photoelectrons which contribute to the formation of the integrated signal up to its maximum.

We also show that when the integration constant and N<sub>int</sub> are small, the energy resolution is even better than the one expected by the Poisson fluctuations.



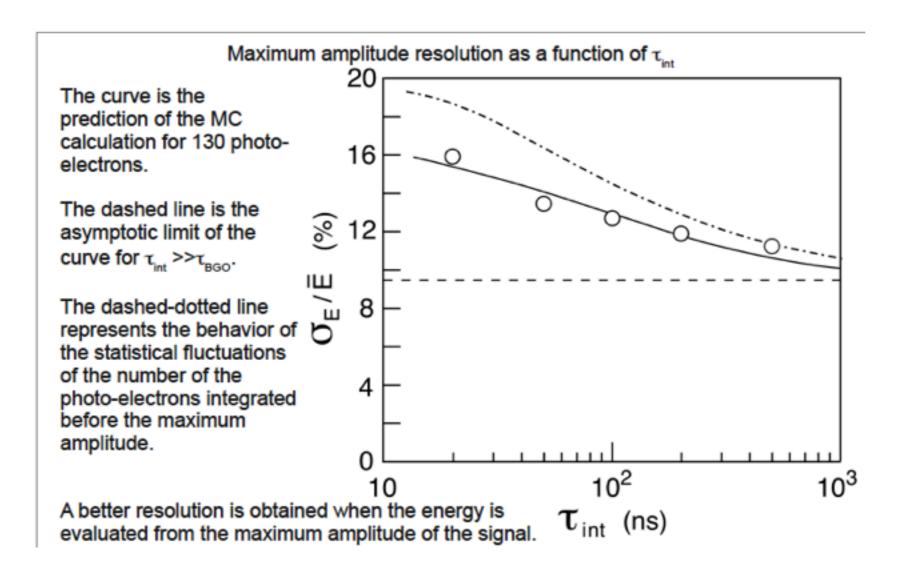


We measured the Energy resolution obtained by integrating all the light provided by a BGO crystal to evaluate the number of photo-electrons and to validate a toy-MC developed to simulate the experimental setup.

## Signal amplitude

In high-rate experiment the measure of the total charge Q takes too long, so the energy deposited in the crystal is often inferred from the maximum amplitude A of the signal integrated with a time constant  $\tau_{\text{int}} \leq \tau_{\text{BGO}}$ .

This procedure, leads to a faster response at the cost of a worse resolution. To determine how this effect depends on  $\tau_{\text{int}}$ , the average values and the widths of the maximum amplitude distributions were evaluated by means of a gaussian fit.



A fast measurement of the energy can be obtained, at the cost of a lower resolution, by integrating the output signal of the photomultiplier over a time shorter than the scintillator decay time and by acquiring the peak amplitude of the integrated signal.

Our studies show that the energy resolution obtained with this method is of the order of the statistical fluctuations of the number of photoelectrons integrated before the peak and even better when this number is relatively small as in the present case.